

Semiconductors
High-reliability discrete products and engineering services since 1977

## 2N6661

## 90V N-CHANNEL MOSFET

## FEATURES

- Available as "HR" (high reliability) screened per MIL-PRF-19500, JANTX level. Add "HR" suffix to base part number.
- Available as non-RoHS ( $\mathrm{Sn} / \mathrm{Pb}$ plating), standard, and as RoHS by adding "-PBF" suffix.

MAXIMUM RATINGS

| Parameter |  | Symbol | Limit | Unit |
| :---: | :---: | :---: | :---: | :---: |
| Drain-Source Voltage |  | $V_{\text {DS }}$ | 90 | V |
| Gate-Source Voltage |  | VGS | $\pm 20$ |  |
| Continuous Drain Current ( $\mathrm{T}^{\prime}=150^{\circ} \mathrm{C}$ ) | $\mathrm{T}_{\mathrm{C}}=25^{\circ} \mathrm{C}$ | ID | 0.86 | A |
|  | $\mathrm{T}_{\mathrm{C}}=100 \mathrm{C}$ |  | 0.54 |  |
| Pulse Drain Current ${ }^{1}$ |  | Idm | 3 |  |
| Maximum Power Dissipation | $\mathrm{T}_{\mathrm{C}}=25^{\circ} \mathrm{C}$ | $\mathrm{P}_{\mathrm{D}}$ | 6.25 | W |
|  | $\mathrm{T}_{\mathrm{A}}=25^{\circ} \mathrm{C}$ |  | 0.725 |  |
| Thermal Resistance, Junction to Ambient |  | $\mathrm{R}_{\text {thJA }}$ | 170 | ${ }^{\circ} \mathrm{C} / \mathrm{W}$ |
| Thermal Resistance, Junction to Case |  | Rthjc | 20 |  |
| Operating Junction and Storage Temperature Range |  | $\mathrm{T}_{\mathrm{J}}, \mathrm{T}_{\text {stg }}$ | -55 to +150 | ${ }^{\circ} \mathrm{C}$ |

Note 1: Pulse width limited by maximum junction temperature

ELECTRICAL CHARACTERISTICS ( $\mathrm{T}_{\mathrm{A}}=25^{\circ} \mathrm{C}$ unless otherwise specified)

| Parameter | Symbol | Test Conditions |  | Limits |  |  | Unit |
| :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: |
|  |  |  |  | Min | Typ ${ }^{2}$ | Max |  |
| STATIC |  |  |  |  |  |  |  |
| Drain-Source Breakdown Voltage | V ${ }_{\text {ds }}$ | $V_{D S}=0 V, l_{D}=10 \mu \mathrm{~A}$ |  | 90 | 125 | - | V |
| Gate-Source Threshold Voltage | $\mathrm{V}_{\text {GS(th) }}$ | $\mathrm{V}_{\mathrm{DS}}=\mathrm{V}_{\mathrm{GS}}, \mathrm{I}_{\mathrm{D}}=1 \mathrm{~mA}$ |  | 0.8 | 1.6 | 2 | V |
|  |  |  | $\mathrm{T}_{\mathrm{A}}=-55^{\circ} \mathrm{C}$ | - | 1.8 | 2.5 |  |
|  |  |  | $\mathrm{T}_{\mathrm{A}}=125^{\circ} \mathrm{C}$ | 0.3 | 1.3 | - |  |
| Gate-Body Leakage | Igss | $\mathrm{V}_{\mathrm{GS}}= \pm 20 \mathrm{~V}$ | $\mathrm{V}_{\mathrm{DS}}=0 \mathrm{~V}$ | - | - | $\pm 100$ | nA |
|  |  |  | $\mathrm{T}_{\mathrm{A}}=125^{\circ} \mathrm{C}$ | - | - | $\pm 500$ |  |
| Zero Gate Voltage Drain Current | loss | $\mathrm{V}_{\mathrm{GS}}=0 \mathrm{~V}$ | $\mathrm{V}_{\mathrm{DS}}=72 \mathrm{~V}$ | - | - | 1 | $\mu \mathrm{A}$ |
|  |  |  | $\mathrm{T}_{\mathrm{A}}=125^{\circ} \mathrm{C}$ | - | - | 100 | $\mu \mathrm{A}$ |
| On-State Drain Current ${ }^{2}$ | $\mathrm{I}_{\mathrm{D} \text { (on) }}$ | $\mathrm{V}_{G S}=10 \mathrm{~V}$ | $\mathrm{V}_{\text {DS }}=10 \mathrm{~V}$ | - | 1.8 | - | mA |
| Drain-Source On-State Resistance ${ }^{2}$ | RDS(on) | $V_{G S}=5 \mathrm{~V}$ | $\mathrm{ld}=0.3 \mathrm{~A}$ | - | 3.8 | 5.3 | $\Omega$ |
|  |  | $V_{G S}=10 \mathrm{~V}$ | $\mathrm{I}_{\mathrm{D}}=1 \mathrm{~A}$ | - | 3.6 | 4 |  |
|  |  |  | $\mathrm{T}_{\mathrm{A}}=125^{\circ} \mathrm{C}$ | - | 6.7 | 7.5 |  |
| Forward Transconductance ${ }^{2}$ | $\mathrm{g}_{\mathrm{fs}}$ | $\mathrm{V}_{\mathrm{DS}}=7.5 \mathrm{~V}, \mathrm{I}_{\mathrm{D}}=0.475 \mathrm{~A}$ |  | 170 | 340 | - | mS |
| Diode Forward Voltage | V ${ }_{\text {S }}$ | $\mathrm{V}_{\mathrm{GS}}=0 \mathrm{~V}, \mathrm{I}_{S}=0.86 \mathrm{~A}$ |  | 0.7 | 0.9 | 1.4 | V |
| DYNAMIC |  |  |  |  |  |  |  |
| Input Capacitance | $\mathrm{C}_{\text {iss }}$ | $V_{G S}=0 \mathrm{~V}$ $\mathrm{~V}_{\mathrm{DS}}=25 \mathrm{~V}, \mathrm{f}=1 \mathrm{MHz}$ |  | - | 35 | 50 | pF |
| Output Capacitance | Coss |  |  | - | 15 | 40 |  |
| Reverse Transfer Capacitance | $\mathrm{C}_{\text {rss }}$ |  |  | - | 2 | 10 |  |
| Drain Source Capacitance | $\mathrm{C}_{\mathrm{ds}}$ |  |  | - | 30 | - |  |



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| Parameter | Symbol | Test Conditions | Limits |  |  | Unit |
| :---: | :---: | :---: | :---: | :---: | :---: | :---: |
|  |  |  | Min | Typ | Max |  |
| SWITCHING ${ }^{3}$ |  |  |  |  |  |  |
| Turn-On Time | ton | $\begin{gathered} V_{D D}=25 \mathrm{~V}, \mathrm{R}_{\mathrm{L}}=23 \Omega, \mathrm{I}_{\mathrm{D}} \approx 1 \mathrm{~A}, \\ V_{G E N}=10 \mathrm{~V}, \mathrm{R}_{\mathrm{g}}=23 \Omega \end{gathered}$ | - | 6 | 10 | nS |
| Turn-Off Time | toff |  | - | 8 | 10 |  |

Note 2. Pulse test: PW $\leq 300 \mu$ s duty cycle $\leq 2 \%$.
Note 3. Switching time is essentially independent of operating temperature.

## MECHANICAL CHARACTERISTICS

| Case | TO-39 |
| :--- | :--- |
| Marking | Alpha-numeric |
| Pin out | See below |




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Ohmic Region Characteristics


Transfer Characteristics


On-Resistance vs. Drain Current

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Output Characteristics for Low Gate Drive


On-Resistance vs. Gate-to-Source Voltage


Normalized On-Resistance vs. Junction Temperature


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